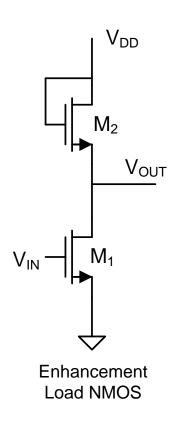
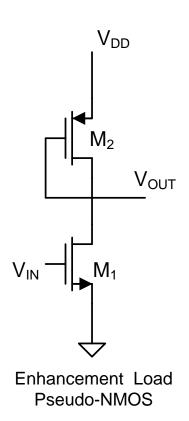
EE 330 Lecture 40

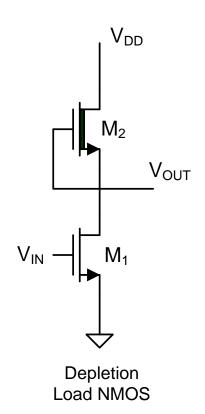
Digital Circuits

Propagation Delay – basic characterization Device Sizing (Inverter and multiple-input gates)

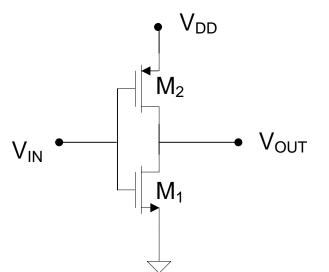
Other MOS Logic Families







Static Power Dissipation in Static CMOS Family

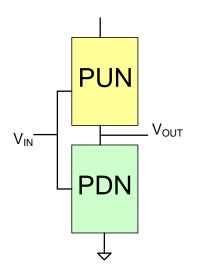


When V_{OUT} is Low, $I_{D1}=0$

When V_{OUT} is High, $I_{D2}=0$

Thus, P_{STATIC}=0

This is a key property of the static CMOS Logic Family and is the major reason Static CMOS Logic is so dominant



It can be shown that this zero static power dissipation property can be preserved if the PUN is comprised of p-channel devices, the PDN is comprised of n-channel devices and they are never both driven into the conducting states at the same time

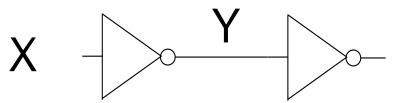
Propagation Delay in Static CMOS Family

Defn: The Propagation Delay of a gate is defined to be the sum of t_{LH} , and t_{LH} , that is, $t_{PROP} = t_{HL} + t_{LH}$

$$t_{PROP} = t_{HL} + t_{LH} \cong C_L (R_{PU} + R_{PD})$$

Propagation delay represents a fundamental limit on the speed a gate can be clocked

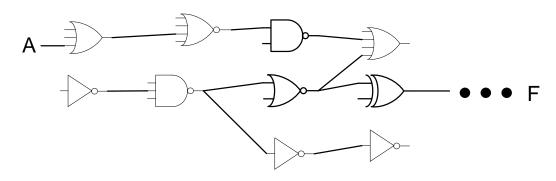
For basic two-inverter cascade in static CMOS logic



In typical process with minimum-sized M_1 and M_2 :

$$t_{PROP} = t_{HL} + t_{LH} \cong 20p \text{ sec}$$

Propagation Delay in Static CMOS Family



Propagation through k levels of logic

$$\begin{split} t_{HL} &\cong t_{HLk} + t_{LH(k-1)} + t_{HL(k-2)} + \bullet \bullet \bullet + t_{XY1} \\ t_{LH} &\cong t_{LHk} + t_{HL(k-1)} + t_{LH(k-2)} + \bullet \bullet \bullet + t_{YX1} \end{split}$$

where x=H and Y=L if k odd and X=L and Y=h if k even

$$t_{PROP} = \sum_{i=1}^{k} t_{PROPk}$$

Will return to propagation delay after we discuss device sizing

Digital Circuit Design

- Hierarchical Design
- Basic Logic Gates
- Properties of Logic Families
- Characterization of CMOS Inverter
- Static CMOS Logic Gates
 - Ratio Logic
- Propagation Delay
 - Simple analytical models
 - Elmore Delay
- Sizing of Gates

- Propagation Delay with Multiple Levels of Logic
- Optimal driving of Large Capacitive Loads
- Power Dissipation in Logic Circuits
- Other Logic Styles
- Array Logic
- Ring Oscillators

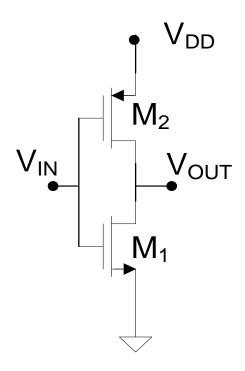
done partial

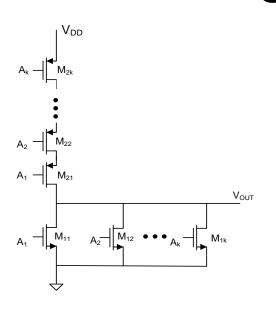
Question:

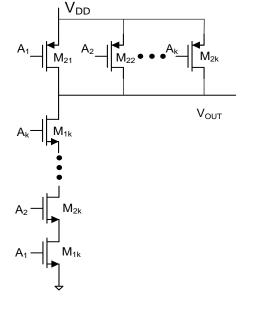


Why is |V_{Tp}| ≈V_{Tn}≈V_{DD}/5 in many processes?





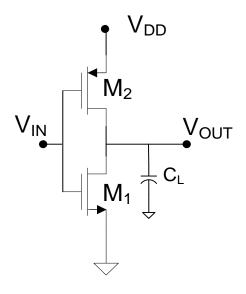




Strategies?

Degrees of Freedom?

Will consider the inverter first



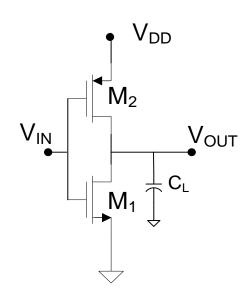
Degrees of Freedom?

Strategies?

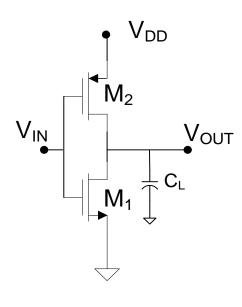
- Since not ratio logic, V_H and V_L are independent of device sizes for this inverter
- With $L_1=L_2=L_{min}$, there are 2 degrees of freedom (W_1 and W_2)

Sizing Strategies

- Minimum Size
- Fixed V_{TRIP}
- Equal rise-fall times (equal worst-case rise and fall times)
- Minimum power dissipation
- Minimum time required to drive a given load
- Minimum input capacitance



Assume V_{Tn} =0.2 V_{DD} , V_{Tp} =-0.2 V_{DD} , μ_n/μ_p =3, L_1 = L_2 = L_{min}



Sizing Strategy: minimum sized

$$W_n = ?, W_p = ?, V_{trip} = ?, t_{HL} = ?, t_{LH} = ?$$

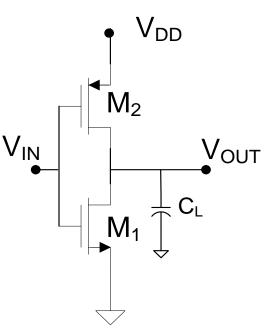
$$\boldsymbol{R}_{PD} = \frac{\boldsymbol{L}_{1}}{\boldsymbol{\mu}_{n}\boldsymbol{C}_{ox}\boldsymbol{W}_{1}(\boldsymbol{V}_{DD} - \boldsymbol{V}_{Tn})}$$

$$\boldsymbol{R}_{\text{PU}} = \frac{\boldsymbol{L}_{\text{2}}}{\boldsymbol{\mu}_{\text{p}}\boldsymbol{C}_{\text{OX}}\boldsymbol{W}_{\text{2}}\!\left(\boldsymbol{V}_{\text{DD}} + \boldsymbol{V}_{\text{Tp}}\right)}$$

$$\boldsymbol{C}_{\text{IN}} = \boldsymbol{C}_{\text{OX}} \big(\boldsymbol{W}_{\! 1} \boldsymbol{L}_{\! 1} + \boldsymbol{W}_{\! 2} \boldsymbol{L}_{\! 2} \big)$$

Assume $V_{Tn}=0.2V_{DD}$, $V_{Tp}=-0.2V_{DD}$, $\mu_n/\mu_p=3$, $L_1=L_2=L_{min}$

Sizing Strategy: minimum sized



$$V_{\text{TRIP}} = \frac{\left(V_{\text{Tn}}\right) + \left(V_{\text{DD}} + V_{\text{Tp}}\right) \sqrt{\frac{\mu_{\text{p}}}{\mu_{\text{n}}}} \frac{W_{\text{2}}}{W_{\text{1}}} \frac{L_{\text{1}}}{L_{\text{2}}}}{1 + \sqrt{\frac{\mu_{\text{p}}}{\mu_{\text{n}}} \frac{W_{\text{2}}}{W_{\text{1}}} \frac{L_{\text{1}}}{L_{\text{2}}}}}$$

$$W_n = ?, W_p = ?, V_{trip} = ?, t_{HL} = ?, t_{LH} = ?$$

$$W_1 = W_2 = W_{MIN}$$

also provides minimum input capacitance

$$t_{HL}=R_{PD}C_{L}$$

 $t_{LH}=3R_{PD}C_{L}$

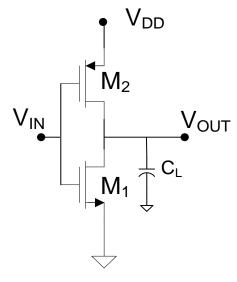
t_{LH} is longer than t_{HL}

$$V_{\text{TRIP}} = \frac{\left(V_{\text{Tn}}\right) + \left(V_{\text{DD}} + V_{\text{Tp}}\right) \sqrt{\frac{\mu_{\text{p}}}{\mu_{\text{n}}}} \frac{W_{\text{2}}}{W_{\text{1}}} \frac{L_{\text{1}}}{L_{\text{2}}}}{1 + \sqrt{\frac{\mu_{\text{p}}}{\mu_{\text{n}}}} \frac{W_{\text{2}}}{W_{\text{1}}} \frac{L_{\text{1}}}{L_{\text{2}}}} \qquad V_{\text{TRIP}} = \frac{\left(0.2 V_{\text{DD}}\right) + \left(V_{\text{DD}} - 0.2 V_{\text{DD}}\right) \sqrt{\frac{1}{3}}}{1 + \sqrt{\frac{1}{3}}} = .42 V_{\text{DD}}$$

Assume $V_{Tn}=0.2V_{DD}$, $V_{Tp}=-0.2V_{DD}$, $\mu_n/\mu_p=3$, $L_1=L_2=L_{min}$

Sizing strategy: Equal (worst case) rise and fall times

$$W_n = ?, W_p = ?, V_{trip} = ?, t_{HL} = ?, t_{LH} = ?$$



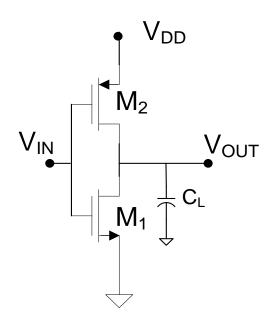
$$R_{PD} = \frac{L_{min}}{\mu_n C_{OX} W_1 \big(0.8 V_{DD}\big)}$$

$$R_{PD} = \frac{L_{min}}{\mu_n C_{OX} W_1 (0.8 V_{DD})}$$

$$R_{PU} = \frac{L_{min}}{3\mu_n C_{OX} W_2 (0.8 V_{DD})}$$

Assume $V_{Tn}=0.2V_{DD}$, $V_{Tp}=-0.2V_{DD}$, $\mu_n/\mu_p=3$, $L_1=L_2=L_{min}$

Sizing strategy: Equal (worst case) rise and fall times



$$\frac{t_{_{LH}}}{t_{_{HL}}} = \frac{R_{_{PU}}C_{_{IN}}}{R_{_{PD}}C_{_{IN}}} \implies R_{_{PU}} = R_{_{PD}}$$

Thus
$$\frac{L_1}{u_n C_{OX} W_1 (V_{DD} - V_{Tn})} = \frac{L_2}{u_p C_{OX} W_2 (V_{DD} + V_{Tp})}$$

with $L_1=L_2$ and $V_{Tp}=-V_{Tn}$ we must

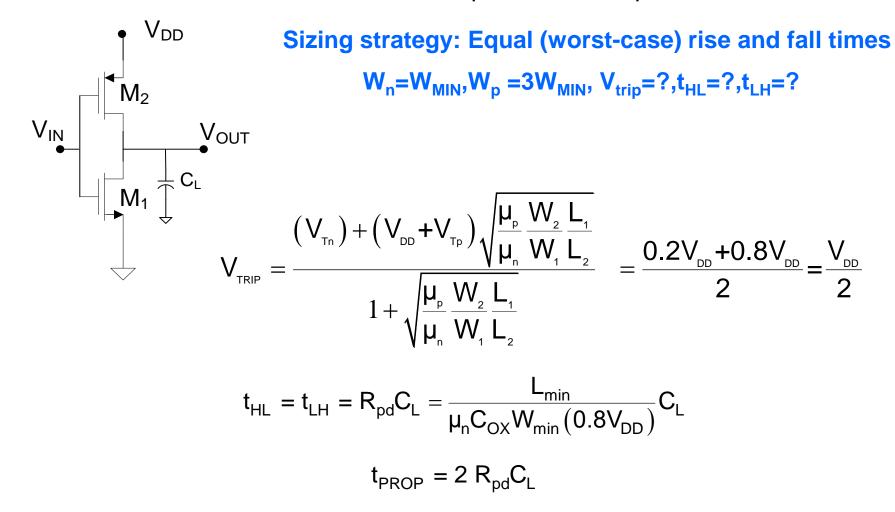
$$\frac{W_2}{W_1} = \frac{\mu_n}{\mu_p} \cong 3$$

What about the second degree of freedom?

$$W_1 = W_{MIN}$$

$$V_{TRIP}=?$$

Assume $V_{Tn}=0.2V_{DD}$, $V_{Tp}=-0.2V_{DD}$, $\mu_n/\mu_p=3$, $L_1=L_2=L_{min}$

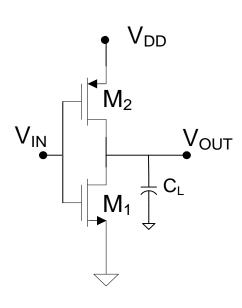


For a fixed C_L, how does t_{prop} compare for the minimum-sizing compared to equal rise/fall sizing?

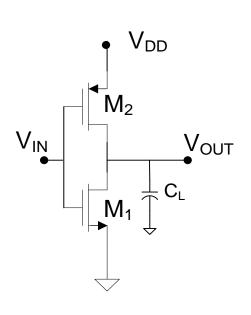
Assume V_{Tn} =0.2 V_{DD} , V_{Tp} =-0.2 V_{DD} , μ_n/μ_p =3, L_1 = L_2 = L_{min}

Sizing strategy: Fixed $V_{TRIP} = V_{DD}/2$

$$W_n = ?, W_p = ?, V_{trip} = ?, t_{HL} = ?, t_{LH} = ?$$



Assume $V_{Tn}=0.2V_{DD}$, $V_{Tp}=-0.2V_{DD}$, $\mu_n/\mu_p=3$, $L_1=L_2=L_{min}$



Sizing strategy: Fixed
$$V_{TRIP} = V_{DD}/2$$

$$V_{n} = ?, \quad V_{p} = ?, \quad V_{trip} = ?, t_{hL} = ?, t_{LH} = ?$$

$$V_{TRIP} = V_{DD}/2$$

$$V_{TRIP} = \frac{(.2V_{DD}) + (V_{DD} - .2V_{DD}) \sqrt{\frac{\mu_p}{\mu_n} \frac{W_2}{W_1} \frac{L_1}{L_2}}}{1 + \sqrt{\frac{\mu_p}{\mu_n} \frac{W_2}{W_1} \frac{L_1}{L_2}}} = \frac{V_{DD}}{2}$$
Solving obtain

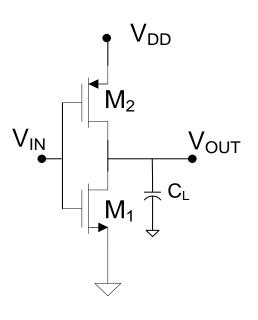
Solving, obtain

$$\frac{W_2}{W_1} = \frac{\mu_n}{\mu_p}$$

$$W_n = W_{MIN}$$
, $W_p = 3W_{MIN}$

- This is the same sizing as was obtained for equal worst-case rise and fall times so $t_{HL}=t_{LH}=R_{pd}C_{L}$
- This is no coincidence !!! Why?
- These properties guide the definition of the process parameters provided by the foundry

Assume V_{Tn} =0.2 V_{DD} , V_{Tp} =-0.2 V_{DD} , μ_n/μ_p =3, L_1 = L_2 = L_{min}

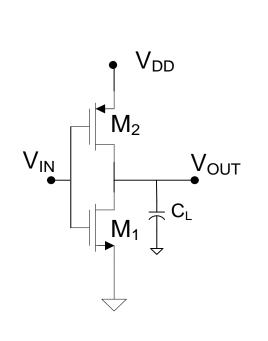


Sizing Strategies

- Minimum Size
- Fixed V_{TRIP}
- Equal rise-fall times (equal worst-case rise and fall times)
- Minimum power dissipation
- Minimum time required to drive a given load
- Minimum input capacitance

Assume $V_{Tn}=0.2V_{DD}$, $V_{Tp}=-0.2V_{DD}$, $\mu_n/\mu_p=3$, $L_1=L_2=L_{min}$

Sizing Strategy Summary



	Minimum Size	$V_{TRIP}=V_{DD}/2$	Equal Rise/Fall
Size	$W_n=W_p=W_{min}$ $L_p=L_n=L_{min}$	$\begin{aligned} W_n &= W_{min} \\ W_{p=} &3 W_{min} \\ L_p &= L_n = L_{min} \end{aligned}$	$W_n=W_{min}$ $W_p=3W_{min}$ $L_p=L_n=L_{min}$
t _{HL}	$R_{pd}C_L$	$R_{pd}C_L$	$R_{pd}C_L$
t _{LH}	$3R_{pd}C_L$	$R_{pd}C_L$	$R_{pd}C_L$
t _{PROP}	$4R_{pd}C_{L}$	$2R_{pd}C_L$	$2R_{pd}C_L$
V _{trip}	$V_{TRIP}=0.42V_{DD}$	$V_{TRIP}=0.5V_{DD}$	$V_{TRIP}=0.5V_{DD}$

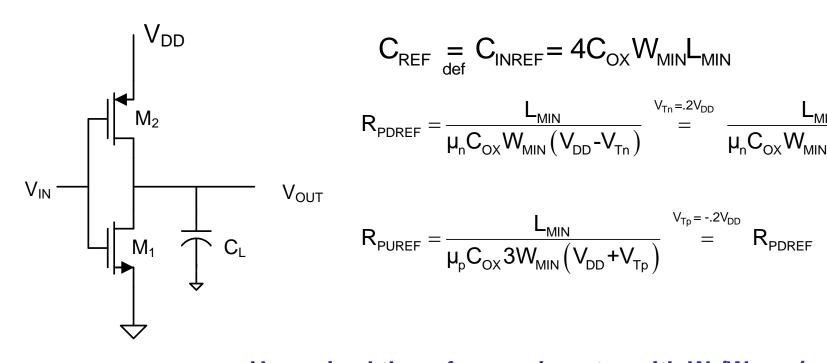
- ullet For a fixed load \mathbf{C}_{L} , the minimum-sized structure has a higher $\mathbf{t}_{\mathsf{PROP}}$ but if the load is another inverter, \mathbf{C}_{L} will also change so the speed improvements become less apparent
- This will be investigated later

Reference Inverter

The reference inverter

Assume
$$\mu_n/\mu_p=3$$
 $L_n=L_p=L_{MIN}$

 $W_n = W_{MIN}, W_p = 3W_n$



$$C_{REF} = C_{INREF} = 4C_{OX}W_{MIN}L_{MIN}$$

$$L_{MIN}$$

$$V_{Tn} = .2V_{DD}$$

$$L_{MIN}$$

$$R_{\text{PDREF}} = \frac{L_{\text{MIN}}}{\mu_{\text{n}} C_{\text{OX}} W_{\text{MIN}} \left(V_{\text{DD}} \text{-} V_{\text{Tn}}\right)} \quad \overset{V_{\text{Tn}} = .2 V_{\text{DD}}}{=} \quad \frac{L_{\text{MIN}}}{\mu_{\text{n}} C_{\text{OX}} W_{\text{MIN}} \left(0.8 V_{\text{DD}}\right)}$$

$$R_{\text{PUREF}} = \frac{L_{\text{MIN}}}{\mu_{\text{p}} C_{\text{OX}} 3W_{\text{MIN}} \left(V_{\text{DD}} + V_{\text{Tp}}\right)} \quad \stackrel{V_{\text{Tp}} = \text{-}.2V_{\text{DD}}}{=} \quad R_{\text{PDREF}}$$

- Have sized the reference inverter with $W_p/W_n = \mu_n/\mu_p$
- In standard processes, provides V_{TRIP} ≈ V_{DD}/2 and t_{HL} ≈ t_{LH}
- Any other sizing strategy could have been used for the reference inverter but this is most convenient

Reference Inverter

The reference inverter pair

Assume $\mu_n/\mu_p=3$ $L_n=L_p=L_{MIN}$

 $W_n = W_{MIN}, W_p = 3W_n$

$$V_{DD}$$
 V_{DD}
 V_{DD}
 V_{OUT}
 V_{OUT}

$$C_{L1} = C_{REF} = 4C_{OX}W_{MIN}L_{MIN}$$

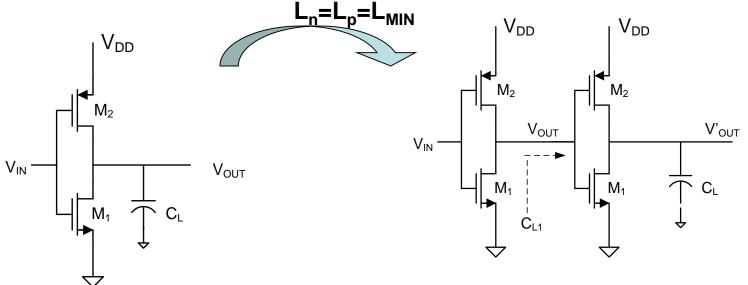
$$t_{REF} = t_{PROPREF} = t_{HLREF} + t_{LHREF} = 2R_{PDREF}C_{REF}$$

Reference Inverter



Assume $\mu_n/\mu_p=3$

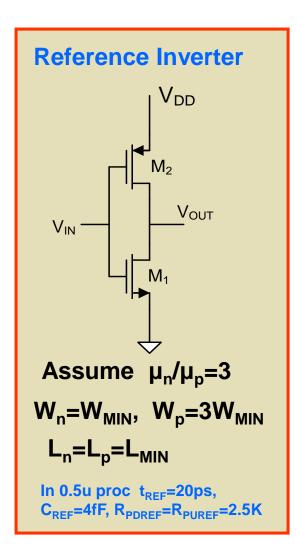
 $W_n = W_{MIN}, W_p = 3W_n$



Summary: parameters defined from reference inverter:

$$\begin{split} &C_{\text{REF}} \!=\! 4C_{\text{OX}} W_{\text{MIN}} L_{\text{MIN}} \\ &R_{\text{PDREF}} \! = \! \frac{L_{\text{MIN}}}{\mu_{\text{n}} C_{\text{OX}} W_{\text{MIN}} \big(V_{\text{DD}} \! - \! V_{\text{Tn}} \big)} \\ &t_{\text{REF}} \! = \! 2R_{\text{PDREF}} C_{\text{REF}} \\ &C_{\text{REF}} \! = \! 4C_{\text{OX}} W_{\text{MIN}} L_{\text{MIN}} \end{split}$$

The Reference Inverter



$$R_{PDREF} = R_{PUREF}$$

$$C_{REF} = C_{IN} = 4C_{OX}W_{MIN}L_{MIN}$$

$$\mathsf{R}_{\mathsf{PDREF}} \! = \! \frac{\mathsf{L}_{\mathsf{MIN}}}{\mathsf{\mu}_{\mathsf{n}} \mathsf{C}_{\mathsf{OX}} \mathsf{W}_{\mathsf{MIN}} \! \left(\mathsf{V}_{\mathsf{DD}} \! - \! \mathsf{V}_{\mathsf{Tn}} \right)}^{V_{\mathsf{Tn}} = .2 V_{\mathsf{DD}}} \! = \! \frac{\mathsf{L}_{\mathsf{MIN}}}{\mathsf{\mu}_{\mathsf{n}} \mathsf{C}_{\mathsf{OX}} \mathsf{W}_{\mathsf{MIN}} \! \left(0.8 \mathsf{V}_{\mathsf{DD}} \right)}$$

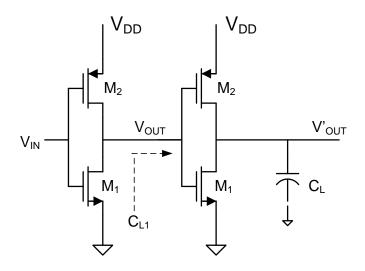
$$t_{HLREF} = t_{LHREF} = R_{PDREF}C_{REF}$$

$$t_{REF} = t_{HLREF} + t_{LHREF} = 2R_{PDREF}C_{REF}$$

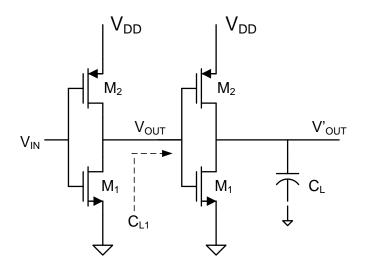
(Note: This C_{OX} is somewhat larger than that in the 0.5u ON process)

Propagation Delay

How does the propagation delay compare for a minimum-sized strategy to that of an equal rise/fall sizing strategy?



Minimum Sized $W_2=W_1=W_{MIN}$



Reference Inverter

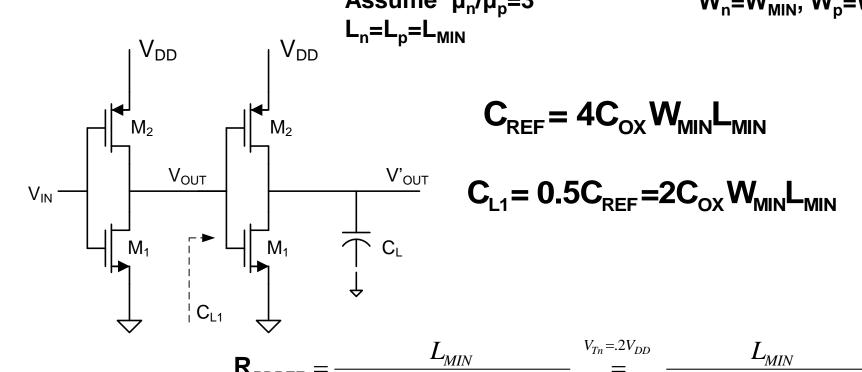
$$W_2 = (\mu_n / \mu_p) W_1, W_1 = W_{MIN}$$

$$t_{PROP} = t_{REF}$$

The minimum-sized inverter pair

Assume $\mu_n/\mu_p=3$

 $W_n = W_{MIN}, W_p = W_n$



$$C_{REF} = 4C_{OX}W_{MIN}L_{MIN}$$

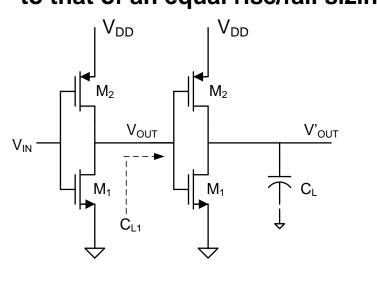
$$C_{L1} = 0.5C_{REF} = 2C_{OX}W_{MIN}L_{MIN}$$

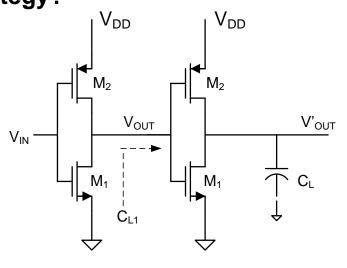
$$\mathsf{R}_{\mathsf{PDREF}} = \frac{L_{\mathit{MIN}}}{\mu_{\mathit{n}} C_{\mathit{OX}} W_{\mathit{MIN}} \left(V_{\mathit{DD}} - V_{\mathit{Tn}} \right)} \ \ \overset{V_{\mathit{Tn}} = .2 V_{\mathit{DD}}}{=} \ \ \frac{L_{\mathit{MIN}}}{\mu_{\mathit{n}} C_{\mathit{OX}} W_{\mathit{MIN}} \left(0.8 V_{\mathit{DD}} \right)}$$

$$\textbf{t}_{\text{PROP}} \!=\! \textbf{t}_{\text{HLREF}} \!+\! \textbf{t}_{\text{LHREF}} \!=\! \textbf{R}_{\text{PDREF}} \left(\textbf{0.5C}_{\text{REF}} \right) + \textbf{3R}_{\text{PDREF}} \left(\textbf{0.5C}_{\text{REF}} \right) = 2 \textbf{R}_{\text{PDREF}} \textbf{C}_{\text{REF}}$$

Propagation Delay

How does the propagation delay compare for a minimum-sized strategy to that of an equal rise/fall sizing strategy?





Minimum Sized

$$W_2=W_1=W_{MIN}$$

$$t_{PROP} = t_{REF}$$

Reference Inverter

$$W_2 = (\mu_n/\mu_p)W_1, W_1 = W_{MIN}$$

$$t_{PROP} = t_{REF}$$

Even though the t_{LH} rise time has been reduced with the equal rise/fall sizing strategy, this was done at the expense of an increase in the total load capacitance that resulted in no net change in propagation delay!

They are the same!

Device Sizing V_{DD} V_{OUT}

Will consider now the multiple-input gates

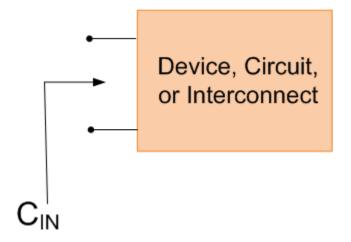
Will consider both minimum sizing and equal worst-case rise/fall

Will assume C_L (not shown)= C_{REF}

Will initially size so gate drive capability is same as that of ref inverter Note: worst-case has been added since fall time in NOR gates or rise time in NAND gates depends upon how many transistors are conducting

Fan In

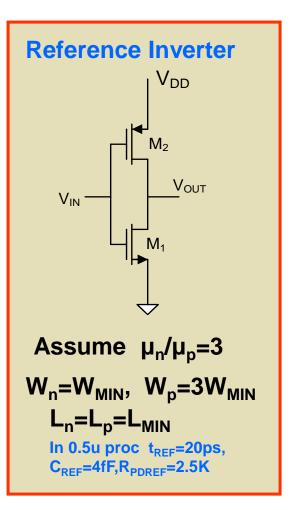
- The Fan In (FI) to an input of a gate device, circuit or interconnect that is capacitive is the input capacitance
- Often this is normalized to some capacitance (typically C_{REF} of ref inverter).



$$FI = C_{IN}$$
 alternately $FI = \frac{C_{IN}}{C_{RFF}}$

Sizing of Multiple-Input Gates

Analysis strategy: Express delays in terms of those of reference inverter



$$\begin{aligned} \textbf{C}_{\text{IN}} = & \textbf{C}_{\text{REF}} = 4\textbf{C}_{\text{OX}}\textbf{W}_{\text{MIN}}\textbf{L}_{\text{MIN}} \\ \textbf{FI}_{\text{REF}} = & \textbf{C}_{\text{REF}} & \text{alternately} & \textbf{FI}_{\text{REF}} = \frac{\textbf{C}_{\text{IN}}}{\textbf{C}_{\text{REF}}} = 1 \\ & \textbf{R}_{\text{PDREF}} = & \textbf{R}_{\text{PUREF}} = \frac{\textbf{L}_{\text{MIN}}}{\mu_{\text{n}}\textbf{C}_{\text{oX}}\textbf{W}_{\text{MIN}}(\textbf{0.8V}_{\text{DD}})} \\ & \textbf{t}_{\text{HLREF}} = & \textbf{t}_{\text{LHREF}} = \textbf{R}_{\text{PDREF}}\textbf{C}_{\text{REF}} \\ & \textbf{t}_{\text{REF}} = & \textbf{t}_{\text{HLREF}} + \textbf{t}_{\text{LHREF}} = 2\textbf{R}_{\text{PDREF}}\textbf{C}_{\text{REF}} \end{aligned}$$

Multiple Input Gates:

2-input NOR

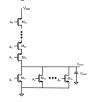
2-input NAND

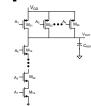
k-input NOR

k-input NAND









Equal Worst Case Rise/Fall (and equal to that of ref inverter when driving CREF)

$$W_n=?$$

$$W_p = ?$$

Fastest response $(t_{HL} \text{ or } t_{LH}) = ?$

Worst case response (t_{PROP} , usually of most interest)?

Input capacitance (FI) = ?

Minimum Sized (assume driving a load of CREF)

$$W_n = W_{min}$$

$$W_p = W_{min}$$

Fastest response $(t_{HL} \text{ or } t_{LH}) = ?$

Slowest response $(t_{HL} \text{ or } t_{LH}) = ?$

Worst case response (t_{PROP} , usually of most interest)?

Input capacitance (FI) = ?

Equal Worst Case Rise/Fall (and equal to that of ref inverter when driving CREF)

Multiple Input Gates: 2-input NOR

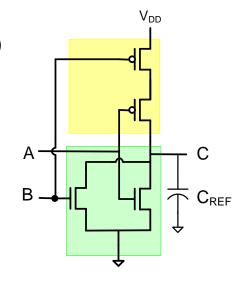
(n-channel devices sized same, p-channel devices sized the same) Assume $L_n = L_p = L_m$ and driving a load of C_{REF}

$$W_n=?$$

DERIVATIONS

$$W_p = ?$$

Input capacitance = ?



$$W_n = W_{MIN}$$

$$W_p = 6W_{MIN}$$

 $C_{INA} = C_{INB} = C_{OX} W_{MIN} L_{MIN} + 6C_{OX} W_{MIN} L_{MIN} = 7C_{OX} W_{MIN} L_{MIN} = \left(\frac{7}{4}\right) 4C_{OX} W_{MIN} L_{MIN} = \left(\frac{7}{4}\right) C_{REF}$

$$FI = \left(\frac{7}{4}\right) C_{REF}$$
 or $FI = \frac{7}{4}$

$$t_{PROP} = t_{REF}$$
 (worst case)

Equal Worst Case Rise/Fall | (and equal to that of ref inverter when driving C_{REF})

 V_{DD}



(n-channel devices sized same, p-channel devices sized the same) Assume L_n=L_p=Lmin and driving a load of C_{REF}

$$W_n=?$$

 $W_p = ?$

Input capacitance = ?

t_{PROP}=? (worst case)

$W_n = W_{MIN}$

$$W_p = 6W_{MIN}$$

DERIVATIONS

One degree of freedom was used to satisfy the constraint indicated

Other degree of freedom was used to achieve equal rise and fall times

$$C_{INA} = C_{INB} = C_{OX} W_{MIN} L_{MIN} + 6C_{OX} W_{MIN} L_{MIN} = 7C_{OX} W_{MIN} L_{MIN} = \left(\frac{7}{4}\right) 4C_{OX} W_{MIN} L_{MIN} = \left(\frac{7}{4}\right) C_{REF}$$

$$FI = \left(\frac{7}{4}\right) C_{REF}$$
 or $FI = \frac{7}{4}$

$$t_{PROP} = t_{REF}$$
 (worst case)

Equal Worst Case Rise/Fall (and equal to that of ref inverter when driving CREF)

Multiple Input Gates: k-input NOR

Wn=?

Wp=?

Input capacitance = ?

FI=?

 $t_{PROP}=?$

 $W_n = W_{MINI}$

 $W_p = 3kW_{MIN}$

$$A_{k} \longrightarrow$$

$$A_{2} \longrightarrow$$

$$A_{1} \longrightarrow$$

$$A_{1} \longrightarrow$$

$$A_{k}$$
 M_{2k}
 A_{2}
 M_{22}
 A_{1}
 M_{11}
 A_{2}
 M_{12}
 M_{12}
 M_{1k}
 M_{1k}

$$C_{\mathsf{INX}} = C_{\mathsf{OX}} \mathsf{W}_{\mathsf{MIN}} \mathsf{L}_{\mathsf{MIN}} + 3k C_{\mathsf{OX}} \mathsf{W}_{\mathsf{MIN}} \mathsf{L}_{\mathsf{MIN}} = \left(3k+1\right) C_{\mathsf{OX}} \mathsf{W}_{\mathsf{MIN}} \mathsf{L}_{\mathsf{MIN}} = \left(\frac{3k+1}{4}\right) 4 C_{\mathsf{OX}} \mathsf{W}_{\mathsf{MIN}} \mathsf{L}_{\mathsf{MIN}} = \left(\frac{3k+1}{4}\right) C_{\mathsf{REF}}$$

$$FI = \left(\frac{3k+1}{4}\right) C_{REF}$$
 or $FI = \frac{3k+1}{4}$

$$t_{PROP} = t_{REF}$$

Equal Worst Case Rise/Fall (and equal to that of ref inverter when driving CREF)

Multiple Input Gates: 2-input NAND

Wn=?

DERIVATIONS

Wp=?

Input capacitance = ?

FI=?

$$t_{PROP}=?$$

$$W_n = 2W_{MIN}$$

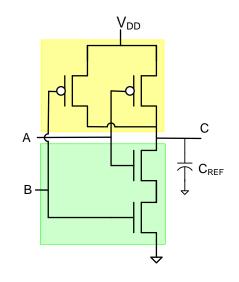
$$W_p = 3W_{MIN}$$

$$C_{INA} = C_{INB} = 2C_{OX}W_{MIN}L_{MIN} + 3C_{OX}W_{MIN}L_{MIN} = \left(5\right)C_{OX}W_{MIN}L_{MIN} = \left(\frac{5}{4}\right)4C_{OX}W_{MIN}L_{MIN} = \left(\frac{5}{4}\right)C_{REF}$$

$$FI = \left(\frac{5}{4}\right) C_{REF}$$
 or $FI = \frac{5}{4}$

$$FI = \frac{5}{4}$$

$$t_{PROP} = t_{REF}$$



Equal Worst Case Rise/Fall (and equal to that of ref inverter when driving C_{REF})

Multiple Input Gates:

DERIVATIONS

k-input NAND

Wn=?

Wp=?

Input capacitance = ?

FI=?

 $t_{PROP}=?$

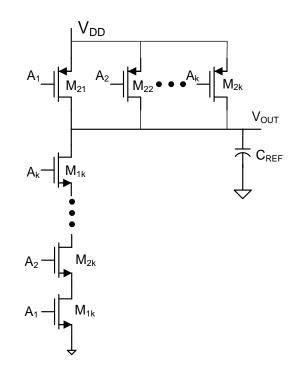
 $W_n = kW_{MIN}$

$$W_p = 3W_{MIN}$$

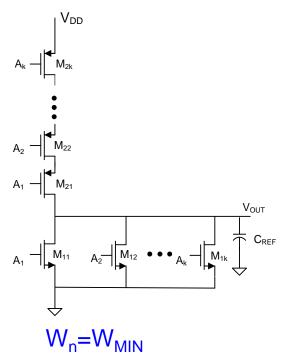
$$C_{\mathsf{INX}} = kC_{\mathsf{OX}} \mathsf{W}_{\mathsf{MIN}} \mathsf{L}_{\mathsf{MIN}} + 3C_{\mathsf{OX}} \mathsf{W}_{\mathsf{MIN}} \mathsf{L}_{\mathsf{MIN}} = \left(3 + k\right) C_{\mathsf{OX}} \mathsf{W}_{\mathsf{MIN}} \mathsf{L}_{\mathsf{MIN}} = \left(\frac{3 + k}{4}\right) 4C_{\mathsf{OX}} \mathsf{W}_{\mathsf{MIN}} \mathsf{L}_{\mathsf{MIN}} = \left(\frac{3 + k}{4}\right) C_{\mathsf{REF}}$$

$$FI = \left(\frac{3+k}{4}\right) C_{REF}$$
 or $FI = \frac{3+k}{4}$

 $t_{PROP} = t_{REF}$



Comparison of NAND and NOR Gates

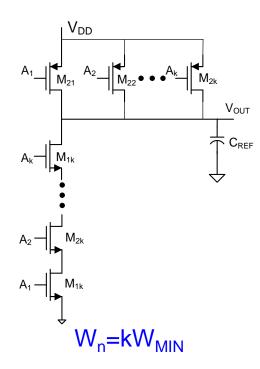


$$W_p = 3kW_{MIN}$$

$$C_{INX} = \left(\frac{3k+1}{4}\right)C_{REF}$$

$$FI = \left(\frac{3k+1}{4}\right) C_{REF}$$
 or $FI = \frac{3k+1}{4}$

$$t_{PROP} = t_{REF}$$



$$W_p = 3W_{MIN}$$

$$C_{INX} = \left(\frac{3+k}{4}\right) C_{REF}$$

$$FI = \left(\frac{3+k}{4}\right) C_{REF}$$
 or $FI = \frac{3+k}{4}$

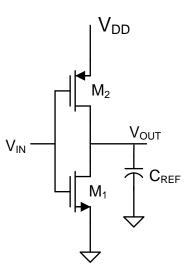
$$t_{PROP} = t_{REF}$$

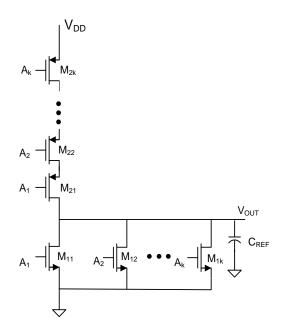
Equal Worse-Case Rise/Fall Device Sizing Strategy

-- (same as V_{TRIP}=V_{DD}/2 for worst case delay in typical process considered in example)

Assume $\mu_n/\mu_p=3$

$$L_n = L_p = L_{MIN}$$





k-input NOR

$$W_n = W_{MIN}, W_p = 3W_{MIN}$$

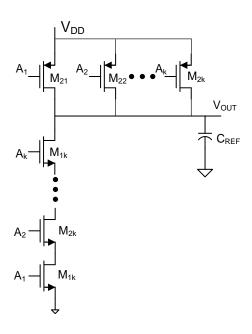
$$C_{IN} = C_{REE}$$

INV

$$W_n = W_{MIN}, W_p = 3kW_{MIN}$$

$$C_{IN} = \left(\frac{3k+1}{4}\right)C_{REF}$$

$$FI = \left(\frac{3k+1}{4}\right)$$



k-input NAND

$$W_n = kW_{MIN}, W_p = 3W_{MIN}$$

$$C_{IN} = \left(\frac{3+k}{4}\right)C_{REF}$$

$$\mathsf{FI} = \left(\frac{3+\mathsf{k}}{4}\right)$$

Multiple Input Gates:

2-input NOR

2-input NAND

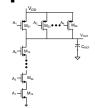
k-input NOR

k-input NAND









Equal Worst Case Rise/Fall (and equal to that of ref inverter when driving C_{REF})

Fastest response $(t_{HL} \text{ or } t_{LH}) = ?$

Worst case response (t_{PROP} , usually of most interest)?

Input capacitance (FI) = ?



Minimum Sized (assume driving a load of C_{REF})

Wn=Wmin

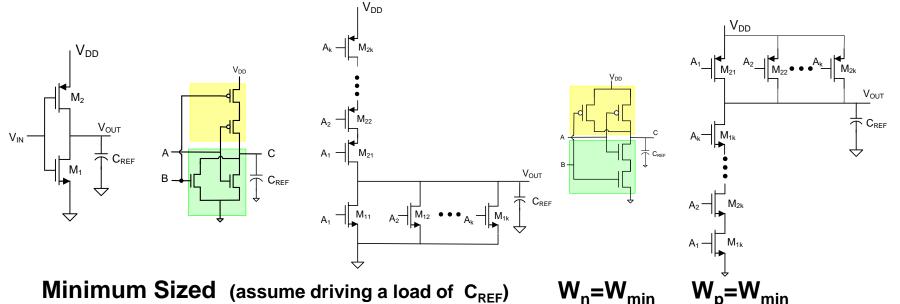
Wp=Wmin

Fastest response $(t_{HI} \text{ or } t_{IH}) = ?$

Slowest response $(t_{HL} \text{ or } t_{LH}) = ?$

Worst case response (t_{PROP} , usually of most interest)?

Input capacitance (FI) = ?



Input capacitance (FI) = ?

$$C_{IN} = C_{OX}W_nL_n + C_{OX}W_pL_p = C_{OX}W_{min}L_{min} + C_{OX}W_{min}L_{min} = 2C_{ox}W_{min}L_{min} = \frac{C_{REF}}{2}$$

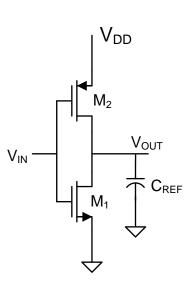
$$FI = \frac{1}{2}$$

Fastest response $(t_{HL} \text{ or } t_{HL}) = ?$

Slowest response $(t_{HL} \text{ or } t_{HL}) = ?$

Worst case response (t_{PROP} , usually of most interest)?

Device Sizing – minimum size driving CREF



INV

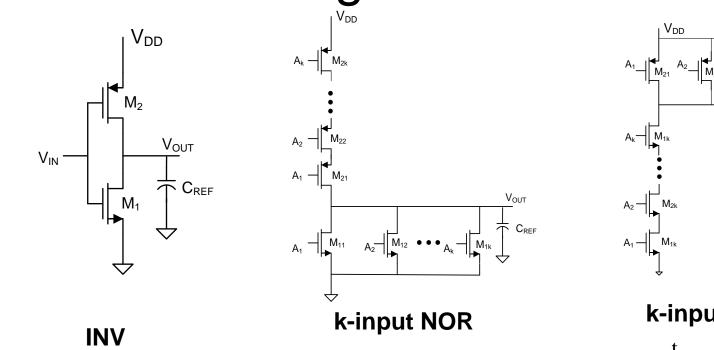
$$t_{PROP} = ?$$

$$\mathbf{t}_{\text{PROP}} = 0.5t_{\text{REF}} + \frac{3}{2}t_{\text{REF}}$$

$$t_{PROP} = 2t_{REF}$$

$$FI = \frac{C_{REF}}{2}$$

$$R_{PU} = R_{PD} = R_{PDREF}$$



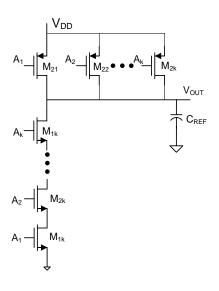
$$t_{PROP} = ?$$

$$t_{PROP} = 0.5t_{REF} + \frac{3k}{2}t_{REF}$$

$$\mathbf{t}_{\text{PROP}} = \left(\frac{3k+1}{2}\right) t_{REF}$$

$$FI = \frac{C_{REF}}{2}$$

$$R_{PD} = R_{PDREF}$$
 $R_{PU} = 3kR_{PDREF}$



k-input NAND

$$t_{PROP} = ?$$

$$t_{PROP} = \frac{3}{2}t_{REF} + \frac{k}{2}t_{REF}$$

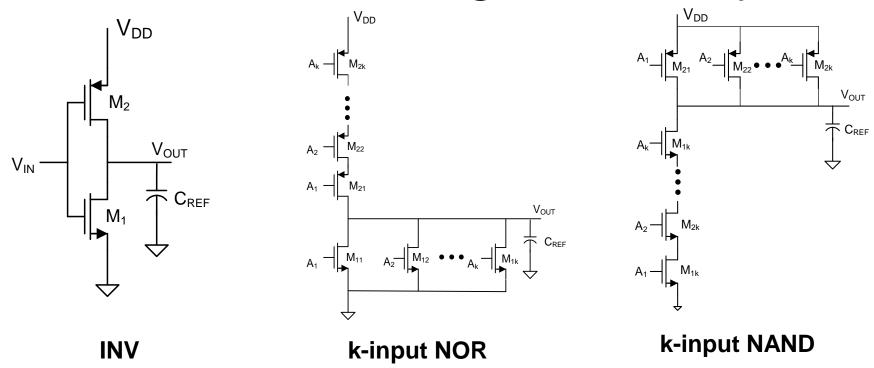
$$t_{PROP} = \frac{3+k}{2}t_{REF}$$

$$FI = \frac{C_{REF}}{2}$$

$$R_{PD} = 3R_{PDREF}$$
 $R_{PU} = 3R_{PDREF}$

$$R_{PU} = 3R_{PDRF}$$

Device Sizing Summary



 C_{IN} for N_{AND} gates is considerably smaller than for NOR gates for equal worst-case rise and fall times

 $C_{\rm IN}$ for minimulm-sized structures is independent of number of inputs and much smaller than $C_{\rm IN}$ for the equal rise/fall time case

R_{PII} gets very large for minimum-sized NOR gate

End of Lecture 40